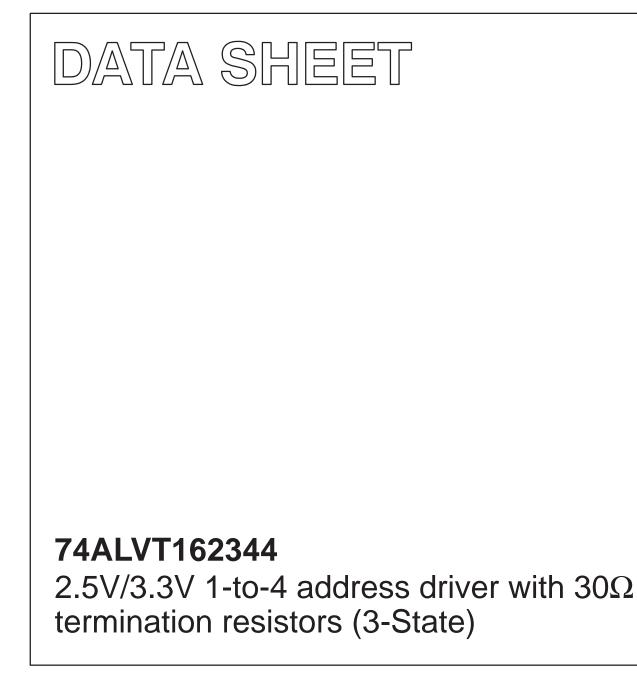
INTEGRATED CIRCUITS



Product specification IC24 Data Handbook 1998 Jun 30



Philips Semiconductors

74ALVT162344

FEATURES

- Multiple V_{CC} and GND pins minimize switching noise
- 5V I/O Compatible
- Live insertion/extraction permitted
- 3-State output buffers
- Power-up 3-State
- Output capability: +12mA/-12mA
- Latch-up protection exceeds 500mA per Jedec JC40.2 Std 17
- ESD protection exceeds 2000 V per MIL STD 883 Method 3015 and 200 V per Machine Model
- Outputs include series resistance of 30Ω making external termination resistors unnecessary

QUICK REFERENCE DATA

DESCRIPTION

The 74ALVT162344 high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive. It is designed for V_{CC} operation at 2.5V or 3.3V with I/O compatibility to 5V.

The 74ALVT162344 is a 1-to-4 address driver used in applications where four separate memory locations must be addressed by a single address.

The 74ALVT162344 is designed with 30Ω series resistance in both the pull-up and pull-down output structures. This design reduces line noise in applications such as memory address drivers, clock drivers, and bus receivers/transmitters.

SYMBOL	PARAMETER	CONDITIONS	TYPI	UNIT	
STMBOL		T _{amb} = 25℃	2.5V	3.3V	ONIT
t _{PLH} t _{PHL}	Propagation delay nAx to nBx or nBx to nAx	$C_L = 50 pF$	3.6 2.3	2.8 2.1	ns
C _{IN}	Input capacitance DIR, \overline{OE}	$V_I = 0V \text{ or } V_{CC}$	3	3	pF
C _{Out}	Output capacitance	$V_{I/O} = 0V \text{ or } V_{CC}$	9	9	pF
I _{CCZ}	Total supply current	Outputs disabled	40	70	μΑ

ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
56-Pin Plastic SSOP Type III	–40°C to +85°C	74ALVT162344 DL	AV162344 DL	SOT371-1
56-Pin Plastic TSSOP Type II	–40°C to +85°C	74ALVT162344 DGG	AV162344 DGG	SOT364-1

PIN DESCRIPTION

PIN NUMBER	SYMBOL	FUNCTION
8, 14, 15, 21, 36, 42, 43, 49	nA	Data inputs
2, 3, 5, 6, 9, 10, 12, 13, 16, 17, 19, 20, 23, 24, 26, 27, 30,31, 33, 34, 37, 38, 40, 44, 45, 47, 48, 51, 52, 54, 55,	nY _X	Data outputs
1, 28, 29, 56	ŌĒ	Output enable inputs (active-Low)
4, 11, 18, 25, 32, 39, 46, 53	GND	Ground (0V)
7, 22, 35, 50	V _{CC}	Positive supply voltage

74ALVT162344

PIN CONFIGURATION

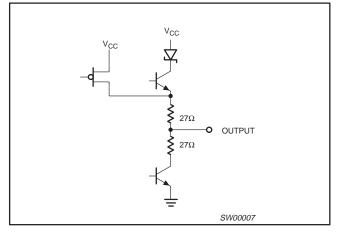
	_			
OE1	1	\bigcirc	56	OE4
1Y0	2		55	8Y0
1Y1	3		54	8Y1
GND	4		53	GND
1Y2	5		52	8Y2
1Y3	6		51	8Y3
V _{CC}	7		50	V _{CC}
1A	8		49	8A
2Y0	9		48	7Y0
2Y1	10		47	7Y1
GND	11		46	GND
2Y2	12		45	7Y2
2Y3	13		44	7Y3
2A	14		43	7A
3A	15		42	6A
3Y0	16		41	6Y0
3Y1	17		40	6Y1
GND	18		39	GND
3Y2	19		38	6Y2
3Y3	20		37	6Y3
4A	21		36	5A
V _{CC}	22		35	V _{CC}
4Y0	23		34	5Y0
4Y1	24		33	5Y1
GND	25		32	GND
4Y2	26		31	5Y2
4Y3	27		30	5Y3
OE2	28		29	OE3
			J	
			SVC	01735

FUNCTION TABLE

INPU	JTS	OUTPUTS	OPERATING MODE	
OE	nA	nYx		
L	L	L	Transparent	
L	Н	Н	Transparent	
Н	Х	Z	High impedance	

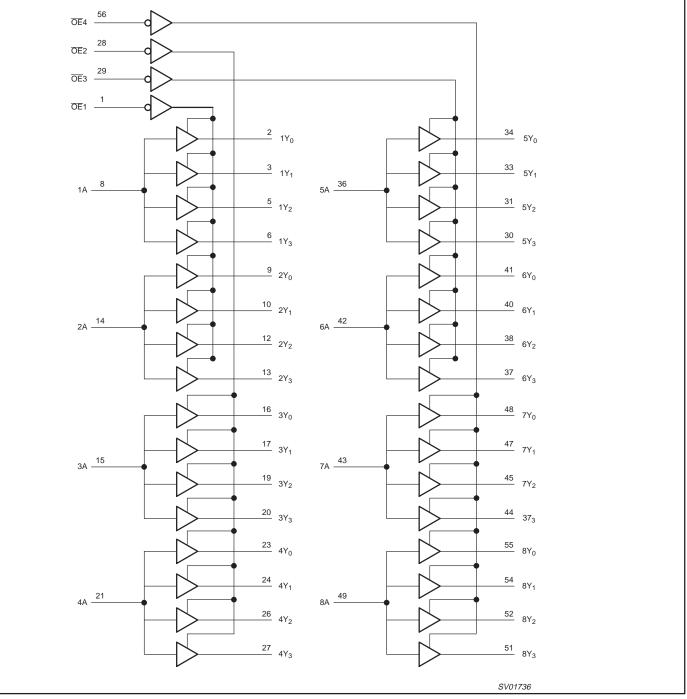
X=Don't careZ=High impedance "off" stateH=High voltage levelL=Low voltage level

SCHEMATIC OF EACH OUTPUT



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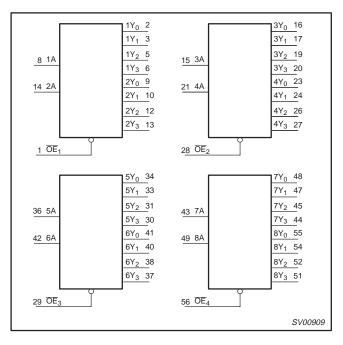
LOGIC DIAGRAM



LOGIC SYMBOL

1998 Jun 30

74ALVT162344



ABSOLUTE MAXIMUM RATINGS^{1, 2}

SYMBOL	PARAMETER CONDITIONS		PARAMETER CONDITIONS		RATING	UNIT
V _{CC}	DC supply voltage		-0.5 to +4.6	V		
I _{IK}	DC input diode current	V ₁ < 0	-50	mA		
VI	DC input voltage ³		-0.5 to +7.0	V		
I _{ОК}	DC output diode current	V _O < 0	-50	mA		
V _{OUT}	DC output voltage ³	Output in Off or High state	-0.5 to +7.0	V		
	DC output current	Output in Low state	128	mA		
IOUT		Output in High state	-64			
T _{stg}	Storage temperature range		-65 to +150	°C		

NOTES:

 Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

 The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.

3. The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

SYMBOL	PARAMETER	2.5V RANG	GE LIMITS	3.3V RANG	UNIT	
STMBOL	FARAMETER	MIN	MAX	MIN	MAX	UNIT
V _{CC}	DC supply voltage	2.3	2.7	3.0	3.6	V
VI	Input voltage	0	5.5	0	5.5	V
V _{IH}	High-level input voltage	1.7		2.0		V
V _{IL}	Input voltage		0.7		0.8	V
I _{ОН}	High-level output current		-8		-12	mA
I _{OL}	Low-level output current		12		12	mA
Δt/Δv	Input transition rise or fall rate; Outputs enabled		10		10	ns/V
T _{amb}	Operating free-air temperature range	-40	+85	-40	+85	°C

RECOMMENDED OPERATING CONDITIONS

74ALVT162344

DC ELECTRICAL CHARACTERISTICS (3.3V ± 0.3V RANGE)

SYMBOL PARAMETER		TEST CONDITIONS			LIMITS		
				Temp =	+85°C		
				MIN	TYP ¹	MAX	1
V _{IK}	Input clamp voltage	V _{CC} = 3.0V; I _{IK} = -18mA			-0.85	-1.2	V
V _{OH}	High-level output voltage	$V_{CC} = 3.0V; I_{OH} = -12mA$		2.0	2.3		V
V _{OL}	Low-level output voltage	V _{CC} = 3.0V; I _{OL} = 12mA			0.5	0.8	V
		$V_{CC} = 3.6V; V_I = V_{CC} \text{ or } GND$	Control pins		0.1	±1	
		$V_{CC} = 0 \text{ or } 3.6 \text{V}; \text{ V}_{I} = 5.5 \text{V}$	Control pins		0.1	10	
I _I	Input leakage current	$V_{CC} = 3.6V; V_{I} = 5.5V$			0.1	10	μA
		$V_{CC} = 3.6V; V_{I} = V_{CC}$	Data pins ⁴		0.1	1	1
		$V_{CC} = 3.6V; V_I = 0$	1		0.1	-5	1
I _{OFF}	Off current	$V_{CC} = 0V; V_{I} \text{ or } V_{O} = 0 \text{ to } 4.5V$	-		0.1	±100	μΑ
	Bus Hold current	$V_{CC} = 3V; V_{I} = 0.8V$		75	130		μΑ
I _{HOLD}	A inputs	$V_{CC} = 3V; V_I = 2.0V$		-75	-200		μA
	, inputo	$V_{I} = 0V \text{ to } 3.6V; V_{CC} = 3.6V^{6}$		±500			μΑ
I_{EX}	Current into an output in the High state when $V_O > V_{CC}$	V _O = 5.5V; V _{CC} = 3.0V			10	125	μA
I _{PU/PD}	Power up/down 3-State output current ³	$V_{CC} \le 1.2$ V; $V_O = 0.5$ V to V_{CC} ; $V_I = GNE OE/OE = Don't care$) or V _{CC} ;		1	±100	μA
I _{OZH}	3-State output High current	V_{CC} = 3.6V; V_{O} = 3.0V; V_{I} = V_{IL} or V_{IH}			0.5	5	μA
I _{OZL}	3-State output Low current	V_{CC} = 3.6V; V_{O} = 0.5V; V_{I} = V_{IL} or V_{IH}			0.5	-5	μA
I _{CCH}		V_{CC} = 3.6V; Outputs High, V_I = GND or V_{CC} , I_O = 0			0.06	0.1	
I _{CCL}	Quiescent supply current	V_{CC} = 3.6V; Outputs Low, V_{I} = GND or V_{CC} , I_{O} = 0			7	8.5	mA
I _{CCZ}]	V_{CC} = 3.6V; Outputs Disabled; V_I = GND	0 or V_{CC} , $I_{O} = 0^5$		0.06	0.1	
ΔI_{CC}	Additional supply current per input pin ²	V_{CC} = 3V to 3.6V; One input at V_{CC} -0.6 Other inputs at V_{CC} or GND	V,		0.05	0.4	mA

NOTES:

All typical values are at V_{CC} = 3.3V and T_{amb} = 25°C.
This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND
This parameter is valid for any V_{CC} between 0V and 1.2V with a transition time of up to 10msec. From V_{CC} = 1.2V to V_{CC} = 3.3V ± 0.3V a transition time of 100µsec is permitted. This parameter is valid for T_{amb} = 25°C only.
Unused pins at V_{CC} or GND.

I_{CCZ} is measured with outputs pulled up to V_{CC} or pulled down to ground.
This is the bus hold overdrive current required to force the input to the opposite state.

AC CHARACTERISTICS (3.3V \pm 0.3V RANGE)

GND = 0V, $t_R = t_F = 2.5$ ns, $C_L = 50$ pF, $R_L = 500\Omega$

SYMBOL PARAMETER		WAVEFORM	T _{an} V _C	UNIT		
			MIN	ТҮР	MAX	
t _{PLH} t _{PHL}	Propagation delay nAx to nYx	1	0.5 0.5	2.8 2.1	4.3 3.1	ns
t _{PZH} t _{PZL}	Output enable time to High and Low level	2	1.0 1.0	3.6 2.8	6.2 4.4	ns
t _{PHZ} t _{PLZ}	Output disable time from High and Low level	2	1.0 1.0	4.5 2.5	6.3 4.3	ns

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DC ELECTRICAL CHARACTERISTICS (2.5V \pm 0.2V RANGE)

SYMBOL PARAMETER		TEST CONDITIONS			LIMITS		
				Temp =	-40°C to	+85°C	UNIT
				MIN	TYP ¹	MAX	
V _{IK}	Input clamp voltage	$V_{CC} = 2.3V; I_{IK} = -18mA$			-0.85	-1.2	V
V _{OH}	High-level output voltage	$V_{CC} = 2.3$ to 2.7V; $I_{OH} = -100\mu A$		V _{CC} -0.2	V _{CC}		v
VOH	nigh-lever output voltage	$V_{CC} = 2.3V; I_{OH} = -8mA$		1.7	2.1		v
Ve	Low-level output voltage	$V_{CC} = 2.3V; I_{OL} = 100\mu A$			0.07	0.2	v
V _{OL}	Low-level output voltage	V _{CC} = 2.3V; I _{OL} = 24mA			0.3	0.5	v
		$V_{CC} = 2.7V; V_I = V_{CC} \text{ or } GND$	Control pins		0.1	±1	
		$V_{CC} = 0 \text{ or } 2.7 \text{V}; \text{ V}_{\text{I}} = 5.5 \text{V}$	Control pins		0.1	10	
I _I	Input leakage current	$V_{CC} = 2.7V; V_{I} = 5.5V$			0.1	10	μA
		$V_{CC} = 2.7V; V_{I} = V_{CC}$	/ _{CC} Data pins ⁴		0.1	1	
		$V_{CC} = 2.7V; V_I = 0$	1		0.1	-5	
I _{OFF}	Off current	$V_{CC} = 0V; V_{I} \text{ or } V_{O} = 0 \text{ to } 4.5V$	-		0.1	±100	μΑ
I _{HOLD}	Bus Hold current	$V_{CC} = 2.5 V; V_{I} = 0.7 V$			106		μΑ
HOLD	A inputs ⁶	V _{CC} = 5.5V; V _I = 1.7V			-70		μΑ
I_{EX}	Current into an output in the High state when $V_O > V_{CC}$	V _O = 5.5V; V _{CC} = 2.3V			10	125	μA
I _{PU/PD}	Power up/down 3-State output current ³	$V_{CC} \le 1.2$ V; $V_{O} = 0.5$ V to V_{CC} ; $V_{I} = GNE OE/OE = Don't care$) or V _{CC}		1	100	μA
I _{OZH}	3-State output High current	V_{CC} = 2.7V; V_{O} = 2.3V; V_{I} = V_{IL} or V_{IH}			0.5	5	μΑ
I _{OZL}	3-State output Low current	V_{CC} = 2.7V; V_{O} = 0.5V; V_{I} = V_{IL} or V_{IH}			0.5	-5	μΑ
I _{CCH}		V_{CC} = 2.7V; Outputs High, V_I = GND or V_{CC} , I_O = 0			0.04	0.1	
I _{CCL}	Quiescent supply current	$V_{CC} = 2.7V$; Outputs Low, $V_I = GND$ or V_{CC} , $I_O = 0$			5.0	6.5	mA
I _{CCZ}	1	V_{CC} = 2.7V; Outputs Disabled; V_I = GNE) or $V_{CC, I_{O}} = 0^{5}$		0.04	0.1	
ΔI_{CC}	Additional supply current per input pin ²	V_{CC} = 2.3V to 2.7V; One input at $V_{CC}\text{0}$ Other inputs at V_{CC} or GND	.6V,		0.04	0.4	mA

NOTES:

1. All typical values are at $V_{CC} = 2.5V$ and $T_{amb} = 25^{\circ}C$. 2. This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND

This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND
This parameter is valid for any V_{CC} between 0V and 1.2V with a transition time of up to 10msec. From V_{CC} = 1.2V to V_{CC} = 2.5V ± 0.2V a transition time of 100µsec is permitted. This parameter is valid for T_{amb} = 25°C only.
Unused pins at V_{CC} or GND.
I_{CCZ} is measured with outputs pulled up to V_{CC} or pulled down to ground.
Not guaranteed.

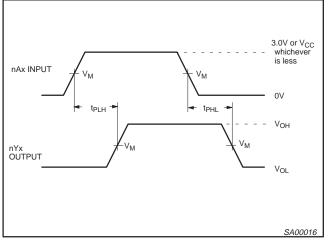
AC CHARACTERISTICS (2.5V \pm 0.2V RANGE) GND = 0V, t_R = t_F = 2.5ns, C_L = 50pF, R_L = 500 Ω

				LIMITS		
SYMBOL	PARAMETER	PARAMETERWAVEFORM $T_{amb} = -40 \text{ to } +85^{\circ}C$ $V_{CC} = +2.5V \pm 0.2V$		UNIT		
			MIN	TYP	MAX	
t _{PLH} t _{PHL}	Propagation delay nAx to nYx	1	0.5 0.5	3.6 2.3	5.8 3.7	ns
t _{PZH} t _{PZL}	Output enable time to High and Low level	2	1.0 1.0	4.6 3.4	8.0 5.3	ns
t _{PHZ} t _{PLZ}	Output disable time from High and Low level	2	1.0 1.0	3.6 3.2	6.1 5.1	ns

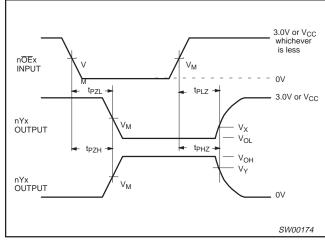
74ALVT162344

AC WAVEFORMS

 $\begin{array}{l} V_M = 1.5 V \mbox{ for } V_{CC} \geq 3.0 V; \mbox{ } V_M = V_{CC}/2 \mbox{ for } V_{CC} \leq 2.7 V \\ V_X = V_{OL} + 0.3 V \mbox{ for } V_{CC} \geq 3.0 V; \mbox{ } V_X = V_{OL} + 0.15 V \mbox{ for } V_{CC} \leq 2.7 V \\ V_Y = V_{OH} - 0.3 V \mbox{ for } V_{CC} \geq 3.0 V; \mbox{ } V_Y = V_{OH} - 0.15 V \mbox{ for } V_{CC} \leq 2.7 V \\ \end{array}$

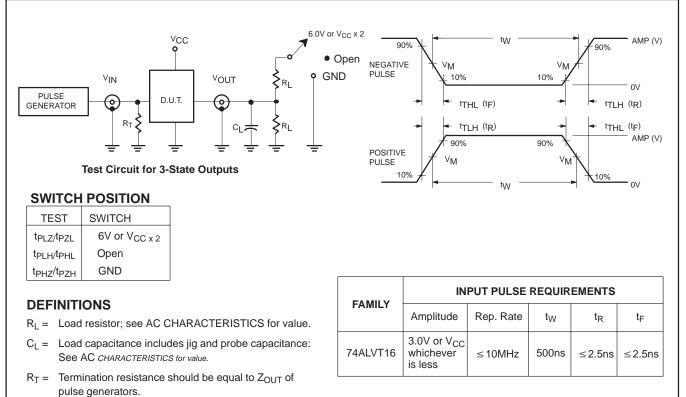


Waveform 1. Input (nAx) to Output (nYx) Propagation Delays



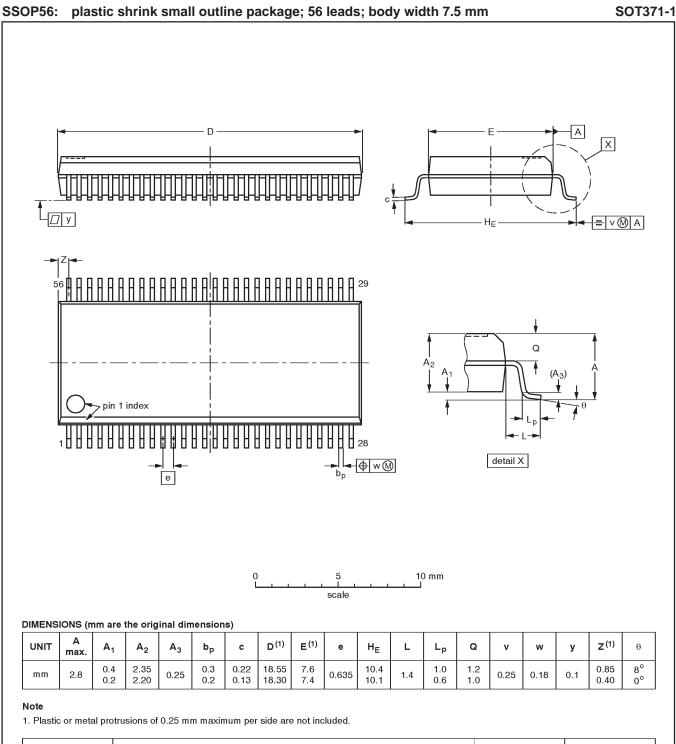
Waveform 2. 3-State Output Enable and Disable Times

TEST CIRCUIT AND WAVEFORM



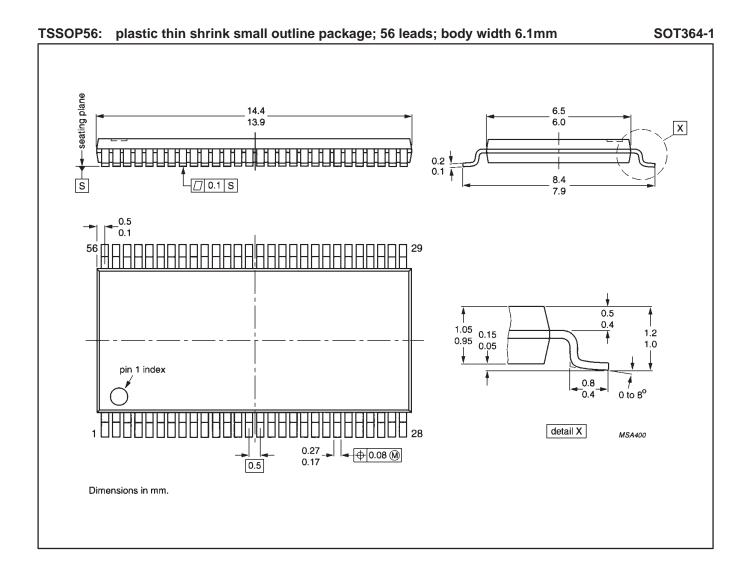
SW00205

74ALVT162344



OUTLINE		REFER	REFERENCES			ISSUE DATE
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT371-1		MO-118AB				-93-11-02 95-02-04





74ALVT162344

NOTES

Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.
Product specification	Production	This data sheet contains final specifications. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.

[1] Please consult the most recently issued datasheet before initiating or completing a design.

Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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